

Drafts

Pending

Active

- L1: (822) radar and dwell and frequency
- L2: (700876) scan or scanning
- L3: (485) 1 and 2
- L4: (2365) 2 same strategy
- L5: (23) 1 and 4
- L6: (3638) (3429) 3 or (3429) 6 or (3429) 5 or (3429) 4 or (3429) 15 or (3429) 16 or (3429) 17 or (3429) 18
- L7: (3778) revise or revising or revisited
- L8: (881470) emitter or transmitter or (signal near source)
- L9: (673) 7 and 8
- L10: (19478) monotonic or monotonically
- L11: (36) 9 and 10

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P: 10675190.wsp.4

Document	Kind of Patent	Number	Date	Title	Notes
US 2083344	USPAT	1937060		System and method of det [NEWH]	
US 2206903	USPAT	1940070		TEXT AVAILABLE IN [Name n	
US 2206896	USPAT	1940070		Radiant energy distance m [HIGGI	
US 2247662	USPAT	1941070		Radiant energy distance m [NEWH	
US 2329570	USPAT	1943091		Device for regulating the re ROBEF	
US 2333688	USPAT	1943110		Distance measuring system;SHEPA	
US 2400309	USPAT	1946051		Oscillation generator [TEX KOCK	
US 2400641	USPAT	1946052		Radio obstacle location a JEAN L	

Average Term	Total	USPAT	PTO	EPO	WO	Others	P	F	D	Patent ID	Spac	App No
342/100	72									US 208344 A	USPAT	1937060
342/101	56									US 2206903 A	USPAT	1940070
342/102	65									US 2206896 A	USPAT	1940070
342/103	95									US 2247662 A	USPAT	1941070
342/13	332									US 2329570 A	USPAT	1943091
342/14	170									US 2333688 A	USPAT	1943110
342/15	125									US 2400309 A	USPAT	1946051
342/16	231									US 2400641 A	USPAT	1946052
342/17	120											

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Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	822	radar and dwell and frequency	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 07:19
L2	700876	scan or scanning	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 07:20
L3	485	1 and 2	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 07:20
L4	2365	2 same strategy	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 07:20
L5	23	1 and 4	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 07:20
L6	3638	((342/13) or (342/14) or (342/15) or (342/16) or (342/16) or (342/17) or (342/18) or (342/19) or (342/88) or (342/89) or (342/90) or (342/91) or (342/92) or (342/93) or (342/94) or (342/95) or (342/96) or (342/97) or (342/98) or (342/99) or (342/100) or (342/101) or (342/102) or (342/103) or (342/192) or (342/195)).CCLS.	US-PGPUB; USPAT	OR	OFF	2004/11/01 08:05
L7	3778	revisit or revisiting or revisited	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 08:06

L8	881470	emitter or transmitter or (signal near5 source)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 08:06
L9	673	7 and 8	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 08:07
L10	19478	monotonic or monotonically	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 08:07
L11	36	9 and 10	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2004/11/01 08:07

## SEARCH NOTES FOR EAST AND IEEE

### SERIAL NUMBER

EAST: search history attached

Search terms: (revisit <or> revisiting <or> revisited) <and> (monotonic <or> monotonically)

### **1 PI-type iterative learning control revisited**

*YangQuan Chen; Moore, K.L.;*

American Control Conference, 2002. Proceedings of the 2002 , Volume: 3 , 8-10 May 2002

Pages:2138 - 2143 vol.3

[\[Abstract\]](#) [\[PDF Full-Text \(594 KB\)\]](#) [IEEE CNF](#)

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### **2 Multi-frame isochronous service for ATM networks: stop-and go revisited**

*Ibaraki, T.; Kameda, T.;*

Computer Communications and Networks, 1997. Proceedings., Sixth International Conference on , 22-25 Sept. 1997

Pages:4 - 10

[\[Abstract\]](#) [\[PDF Full-Text \(800 KB\)\]](#) [IEEE CNF](#)

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### **3 Noise resistance of heterojunction bipolar transistors**

*Anwar, A.F.M.; Jahan, M.K.;*

High Speed Semiconductor Devices and Circuits, 1995. Proceedings., IEEE/Cornell Conference on Advanced Concepts in , 7-9 Aug. 1995

Pages:296 - 302

N/A